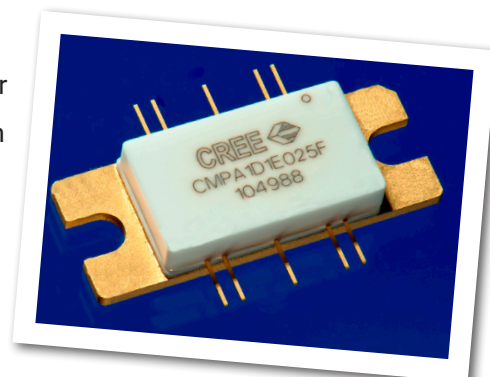


CMPA1D1E025F

25 W, 13.75 - 14.5 GHz, 40 V, Ku-Band GaN MMIC, Power Amplifier

Cree's CMPA1D1E025F is a gallium nitride (GaN) High Electron Mobility Transistor (HEMT) based monolithic microwave integrated circuit (MMIC) on a silicon carbide (SiC) substrate, using a 0.25 μm gate length fabrication process. The Ku Band 25W MMIC is targeted for commercial Ku Band satellite communications applications. It offers high gain and superior efficiency while meets OQPSK linearity required for Satcom applications at 3dB backed off Psat operations. This Ku Band MMIC is available in a 10 lead, 25 mm x 9.9 mm metal/ceramic flanged package.



PN: CMPA1D1E025F
Package Type:440213

Typical Performance Over 13.75-14.5 GHz ($T_c = 25^\circ\text{C}$)

Parameter	13.75 GHz	14.0 GHz	14.25 GHz	14.5 GHz	Units
Small Signal Gain	24	24.5	24.5	24	dB
Linear Output Power	24	23	21	20	W
Power Gain	21	21	20	20	dB
Power Added Efficiency	22	20	18	18	%

Note¹: Measured at -30 dBc, 1.6 MHz from carrier, in the CMPA1D1E025F-AMP under OQPSK modulation, 1.6 Msps, PN23, Alpha Filter = 0.2.

Features

- 24 dB Small Signal Gain
- 40 W Typical Pulsed P_{SAT}
- Operation up to 40 V
- 20 W linear power under OQPSK
- Class A/B high gain, high efficiency 50 ohm MMIC Ku Band high power amplifier

Applications

- Satellite Communications Uplink

Absolute Maximum Ratings (not simultaneous)

Parameter	Symbol	Rating	Units	Conditions
Drain-source Voltage	V_{DS}	84	V_{DC}	25°C
Gate-source Voltage	V_{GS}	-10, +2	V_{DC}	25°C
Power Dissipation	P_{DISS}	94	W	
Storage Temperature	T_{STG}	-55, +150	°C	
Operating Junction Temperature	T_J	225	°C	
Maximum Forward Gate Current	I_{GMAX}	10	mA	25°C
Soldering Temperature ¹	T_S	245	°C	
Screw Torque	τ	40	in-oz	
Thermal Resistance, Junction to Case	$R_{\theta JC}$	1.5	°C/W	$P_{DISS} = 94 \text{ W}, 85^\circ\text{C}$
Case Operating Temperature	T_C	-40, +85	°C	CW, $P_{DISS} = 94 \text{ W}$

Note:

¹ Refer to the Application Note on soldering at www.cree.com/products/wireless_appnotes.asp

Electrical Characteristics (Frequency = 13.75 GHz to 14.5 GHz unless otherwise stated; $T_C = 25^\circ\text{C}$)

Characteristics	Symbol	Min.	Typ.	Max.	Units	Conditions
DC Characteristics¹						
Gate Threshold	$V_{GS(TH)}$	-3.8	-3.0	-2.3	V	$V_{DS} = 10 \text{ V}, I_D = 18.2 \text{ mA}$
Gate Quiescent Voltage	V_Q	–	-2.7	–	V	$V_{DS} = 40 \text{ V}, I_D = 240 \text{ mA}$
Saturated Drain Current ²	I_{DS}	14.6	16.4	–	A	$V_{DS} = 6.0 \text{ V}, V_{GS} = 2.0 \text{ V}$
Drain-Source Breakdown Voltage	V_{BD}	84	100	–	V	$V_{GS} = -8 \text{ V}, I_D = 18.2 \text{ mA}$
RF Characteristics³						
Small Signal Gain	S21	20.9	24	–	dB	$V_{DD} = 40 \text{ V}, I_{DQ} = 240 \text{ mA}, P_{IN} = -15 \text{ dBm}$
Input Return Loss	S11	–	-7	-6	dB	$V_{DD} = 40 \text{ V}, I_{DQ} = 240 \text{ mA}, P_{IN} = -15 \text{ dBm}$
Output Return Loss	S22	–	-7	-6	dB	$V_{DD} = 40 \text{ V}, I_{DQ} = 240 \text{ mA}, P_{IN} = -15 \text{ dBm}$
Output Mismatch Stress	VSWR	–	–	5:1	Ψ	No damage at all phase angles, $V_{DD} = 40 \text{ V}, I_{DQ} = 240 \text{ mA}$, $P_{OUT} = 41 \text{ dBm}$ OQPSK

Notes:

¹ Measured on-wafer prior to packaging.

² Scaled from PCM data.

³ Measured in the CMPA1D1E025F-AMP

Electrical Characteristics Continued... ($T_c = 25^\circ\text{C}$)

Characteristics	Symbol	Min.	Typ.	Max.	Units	Conditions
RF Characteristics^{1,2,3,4}						
Power Added Efficiency	PAE1	14.5	18.6	–	%	$V_{DD} = 40\text{ V}$, $I_{DQ} = 240\text{ mA}$, Frequency = 13.75 GHz
Power Added Efficiency	PAE2	12.5	16.4	–	%	$V_{DD} = 40\text{ V}$, $I_{DQ} = 240\text{ mA}$, Frequency = 14.5 GHz
Power Gain	G_{P1}	19.25	23.3	–	dB	$V_{DD} = 40\text{ V}$, $I_{DQ} = 240\text{ mA}$, Frequency = 13.75 GHz
Power Gain	G_{P2}	17.75	22.1	–	dB	$V_{DD} = 40\text{ V}$, $I_{DQ} = 240\text{ mA}$, Frequency = 14.5 GHz
OQPSK Linearity	ACLR1	–	-40	-32	dBc	$V_{DD} = 40\text{ V}$, $I_{DQ} = 240\text{ mA}$, Frequency = 13.75 GHz
OQPSK Linearity	ACLR2	–	-38	-30.5	dBc	$V_{DD} = 40\text{ V}$, $I_{DQ} = 240\text{ mA}$, Frequency = 14.5 GHz

Notes:

¹ Measured in the CMPA1D1E025F-AMP

² Under OQPSK modulated signal, 1.6 Msps, PN23, Alpha Filter = 0.2.

³ Measured at $P_{AVE} = 41\text{ dBm}$.

⁴ Fixture loss de-embedded.

Electrostatic Discharge (ESD) Classifications

Parameter	Symbol	Class	Test Methodology
Human Body Model	HBM	1A (> 250 V)	JEDEC JESD22 A114-D
Charge Device Model	CDM	II (200 < 500 V)	JEDEC JESD22 C101-C

Typical Performance

Figure 1. - Small Signal S-parameters
CPA1D1E025F in Test Fixture
 $V_{DD} = 40V, I_{DQ} = 240\text{ mA}, T_{case} = 25^{\circ}C$

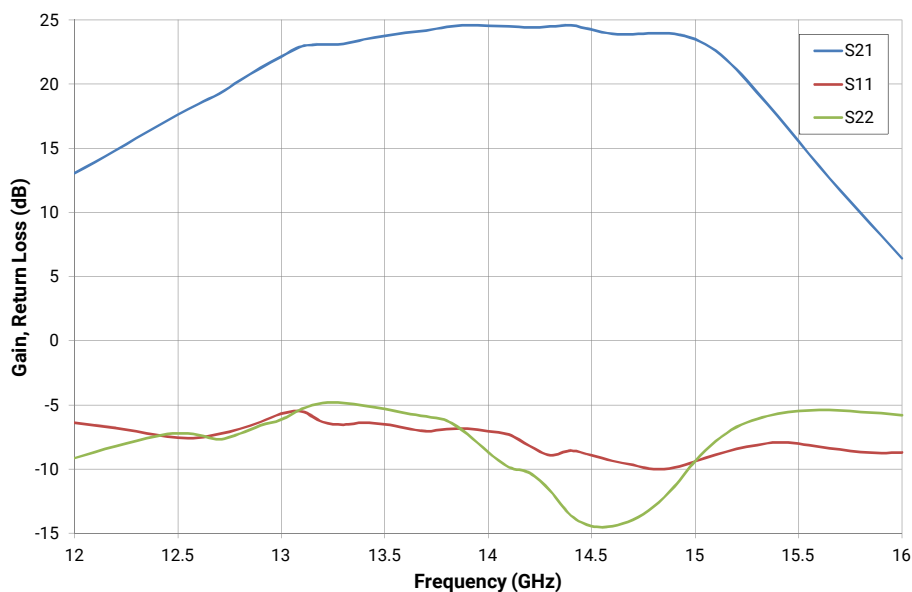
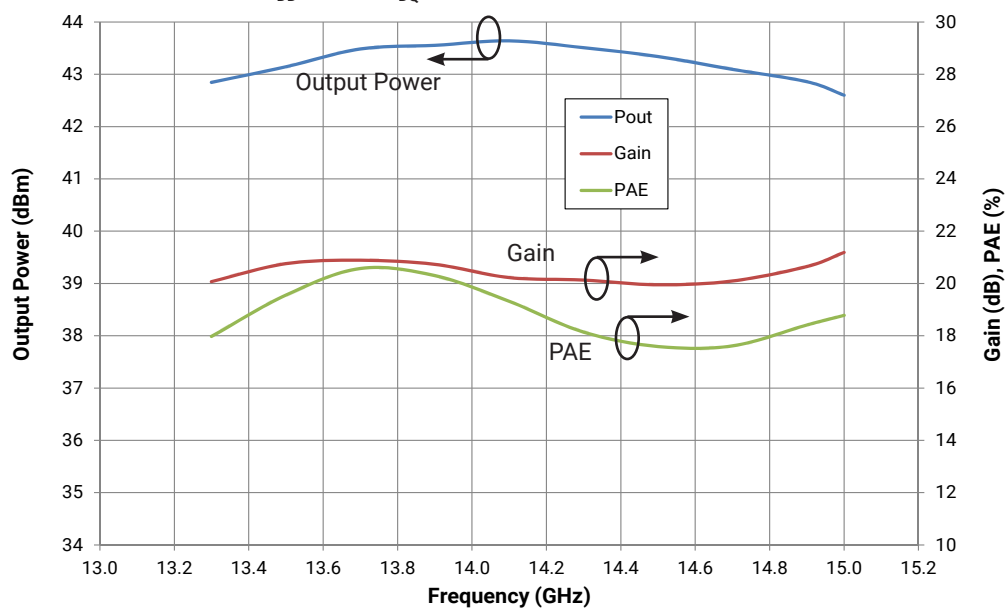


Figure 2. - Modulated @ Spectral Regrowth = -30dBc, 1.6 MHz from Carrier
1.6 Msps OQPSK Modulation
 $V_{DD} = 40\text{ V}, I_{DQ} = 240\text{ mA}, T_{case} = 25^{\circ}C$



Typical Performance

Figure 3. - Spectral Mask @ Average Output Power = 41dBm
1.6 Msps OQPSK Modulation
 $V_{DD} = 40\text{ V}$, $I_{DQ} = 240\text{ mA}$, $T_{case} = 25^{\circ}\text{C}$

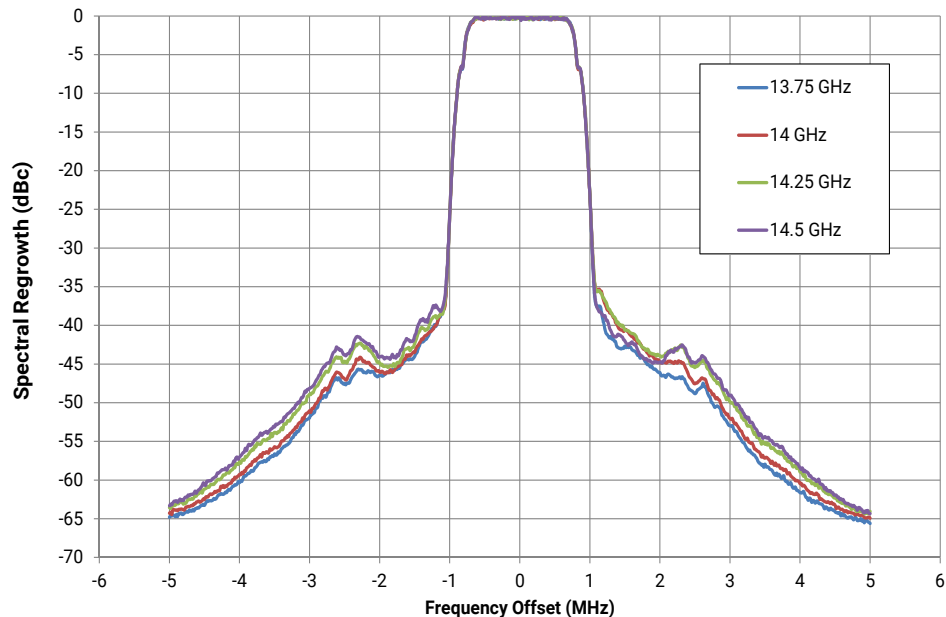
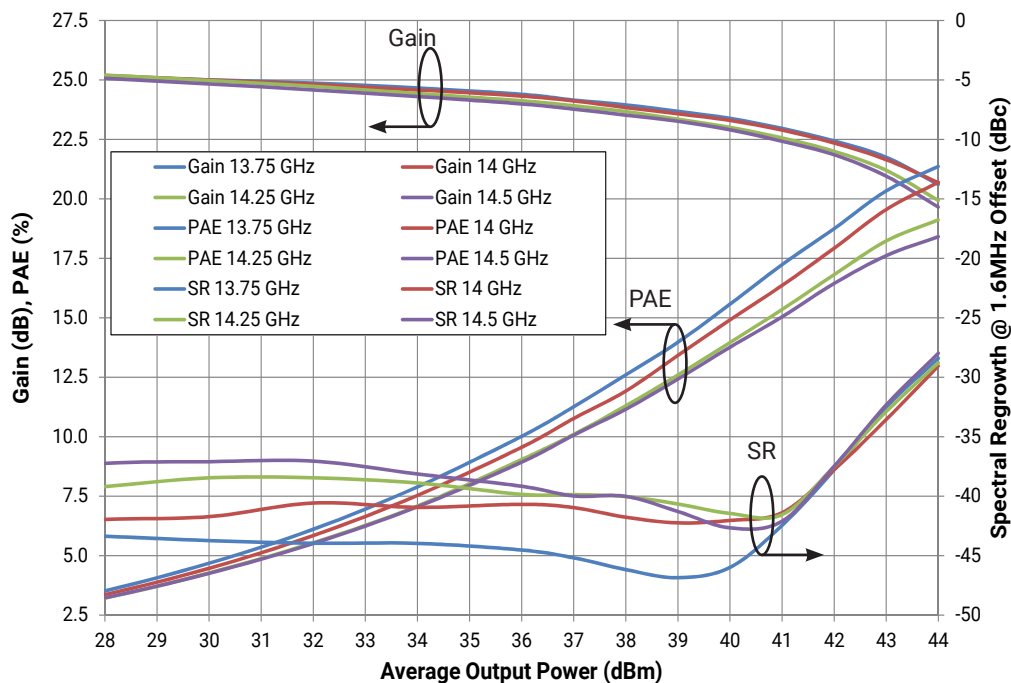


Figure 4. - CMPA1D1E025F Modulated Power Sweep
1.6 Msps OQPSK Modulation
 $V_{DD} = 40\text{ V}$, $I_{DQ} = 240\text{ mA}$, $T_{case} = 25^{\circ}\text{C}$



Typical Performance

Figure 5. - Modulated Power Sweep
1.6 Msps OQPSK Modulation
 $V_{DD} = 40\text{ V}$, $I_{DQ} = 240\text{ mA}$, $T_{case} = 25^\circ\text{C}$

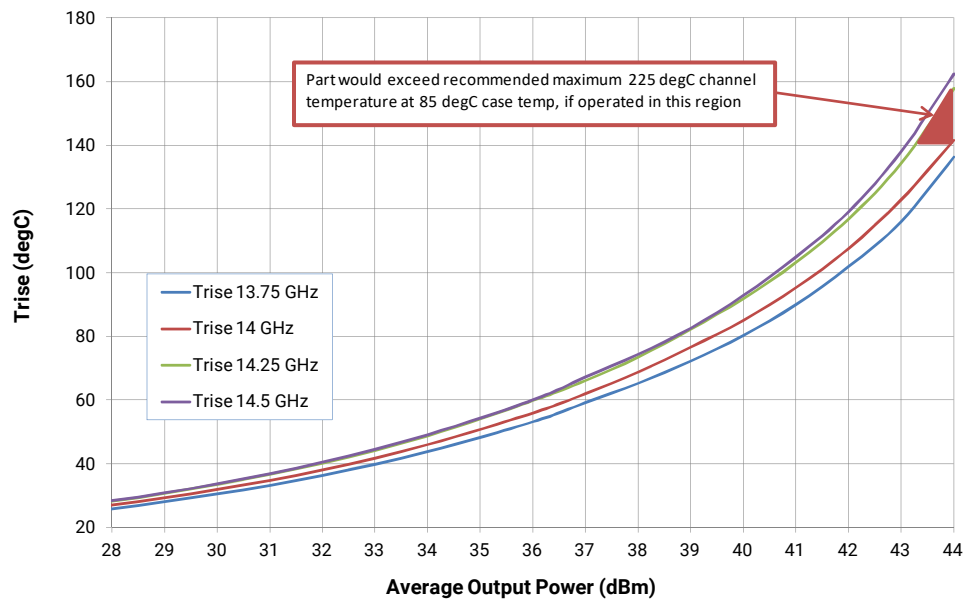
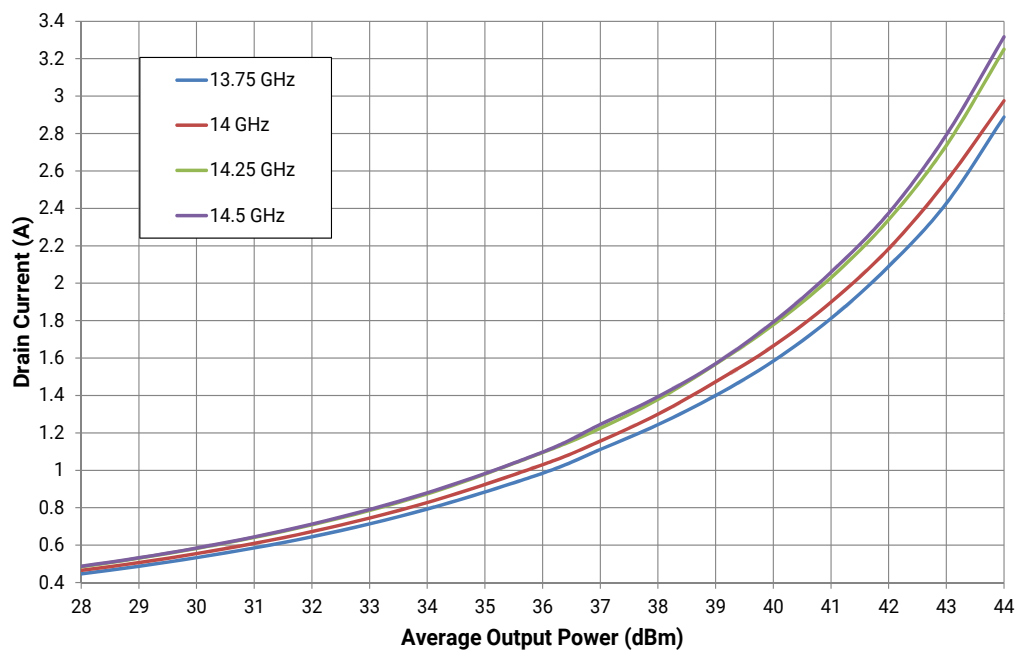


Figure 6. - CMPA1D1E025F Modulated Power Sweep
1.6 Msps OQPSK Modulation
 $V_{DD} = 40\text{ V}$, $I_{DQ} = 240\text{ mA}$, $T_{case} = 25^\circ\text{C}$



Typical Performance

Figure 7. - CMPA1D1E025F Two Tone Power Sweep

IMD3 @ 1 MHz Carrier Spacing

$V_{DD} = 40\text{ V}$, $I_{DQ} = 240\text{ mA}$, $T_{case} = 25^\circ\text{C}$

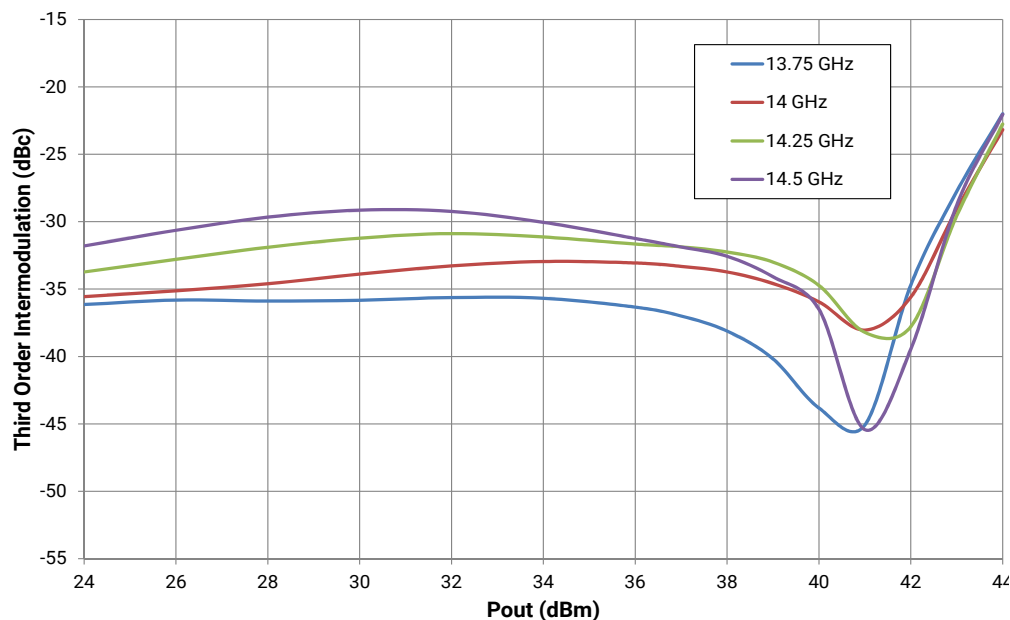
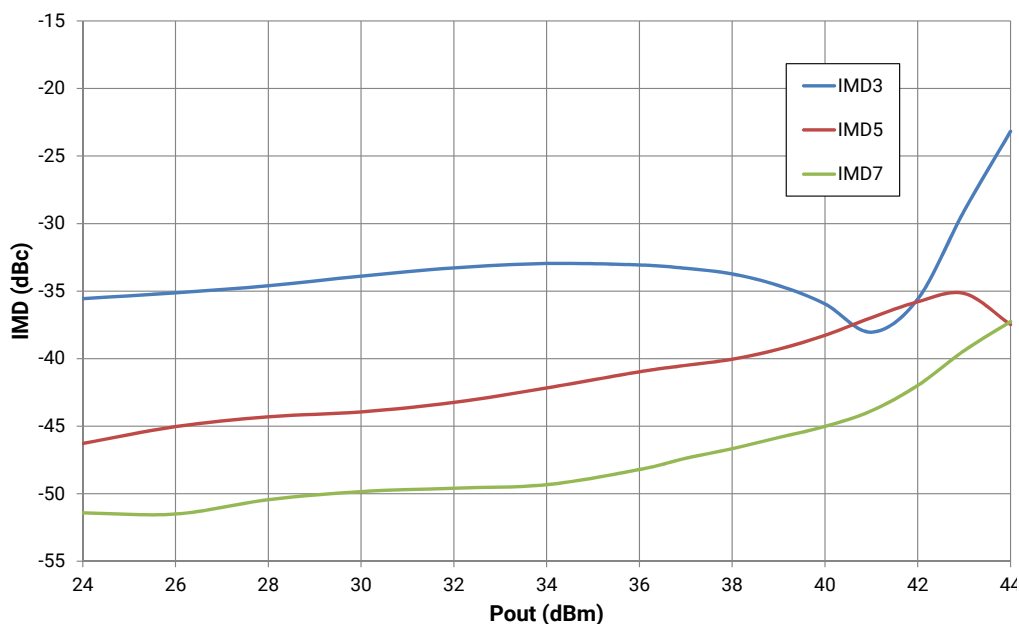


Figure 8. - Two Tone Power Sweep

IMD @ 1 MHz Carrier Spacing, 14 GHz

$V_{DD} = 40\text{ V}$, $I_{DQ} = 240\text{ mA}$, $T_{case} = 25^\circ\text{C}$



Typical Performance

Figure 9. - Two Tone Carrier Spacing Sweep @ 38 dBm Average Output Power, 14 GHz
 $V_{DD} = 40\text{ V}$, $I_{DQ} = 1\text{ A}$, $T_{case} = 25^\circ\text{C}$

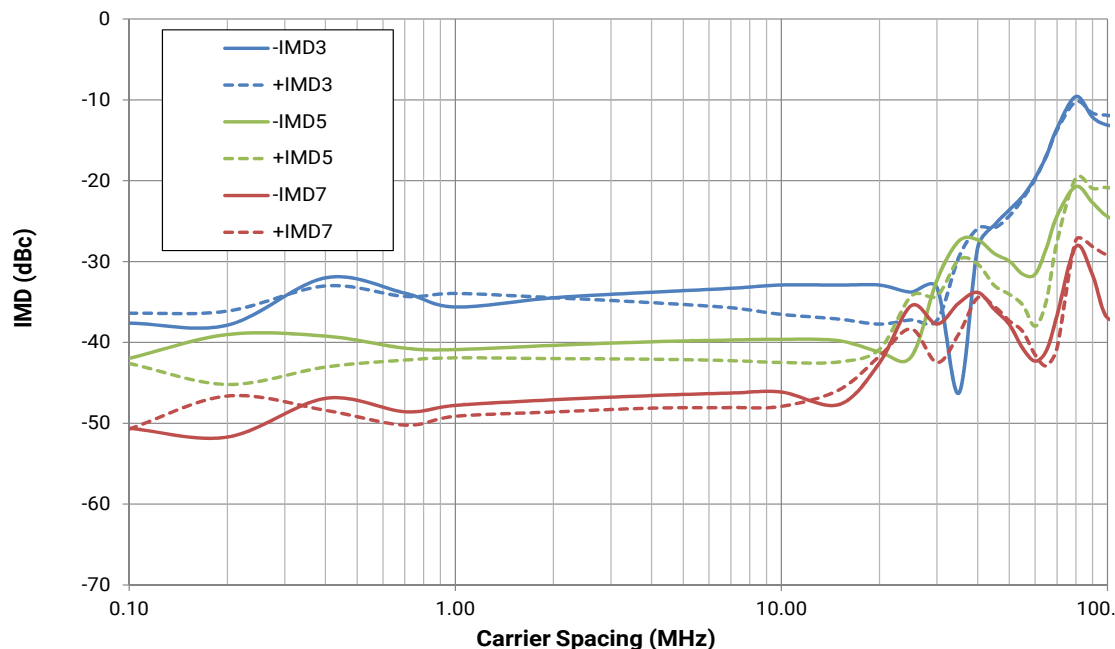
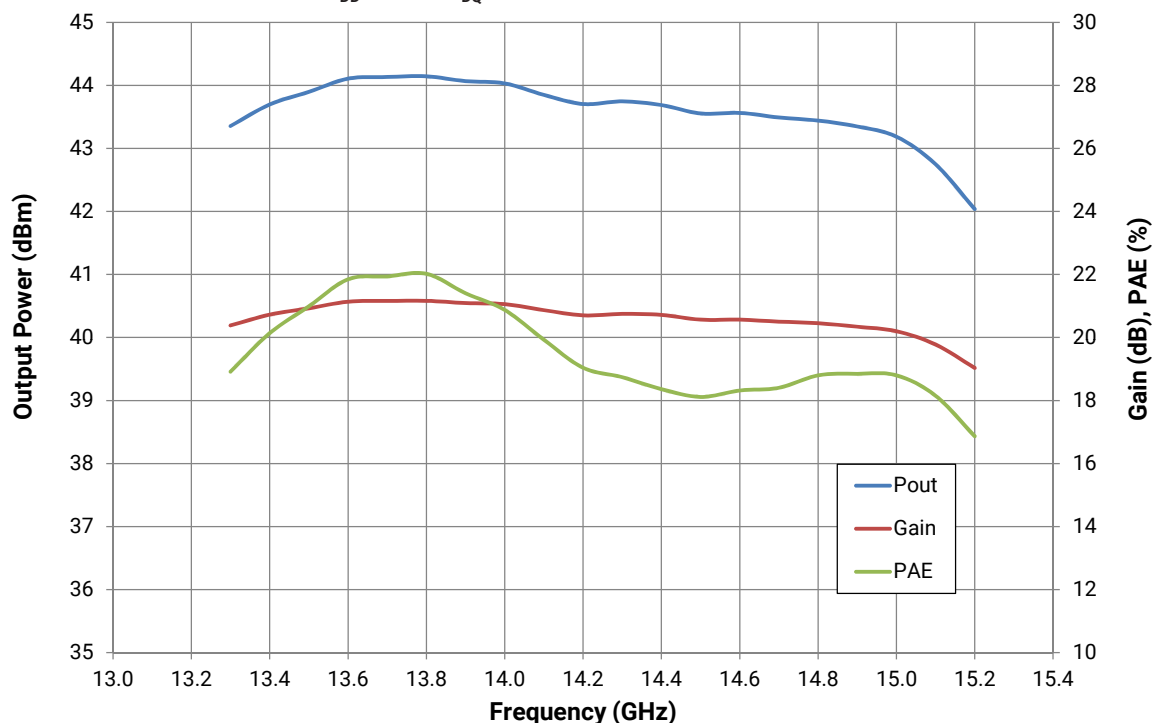


Figure 10. - CW vs. Frequency @ $P_{IN} = 23\text{ dBm}$
 $V_{DD} = 40\text{ V}$, $I_{DQ} = 240\text{ mA}$, $T_{case} = 25^\circ\text{C}$



Typical Performance

Figure 11. - CW Power Sweep CMPA1D1E025F in Test Fixture
 $V_{DD} = 40V$, $I_{DQ} = 240\text{ mA}$, $T_{case} = 25^{\circ}C$

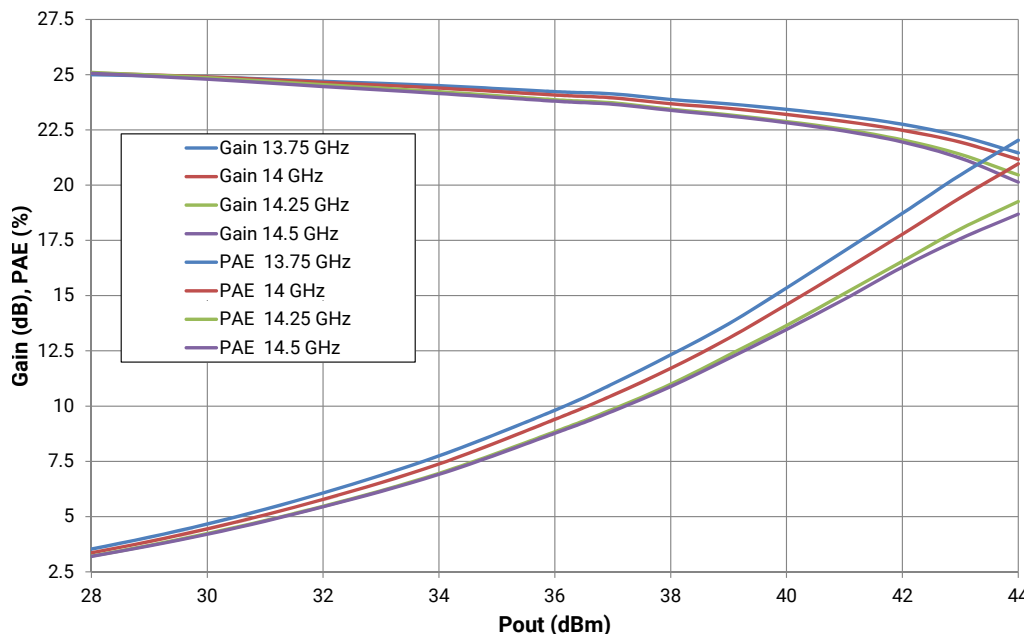
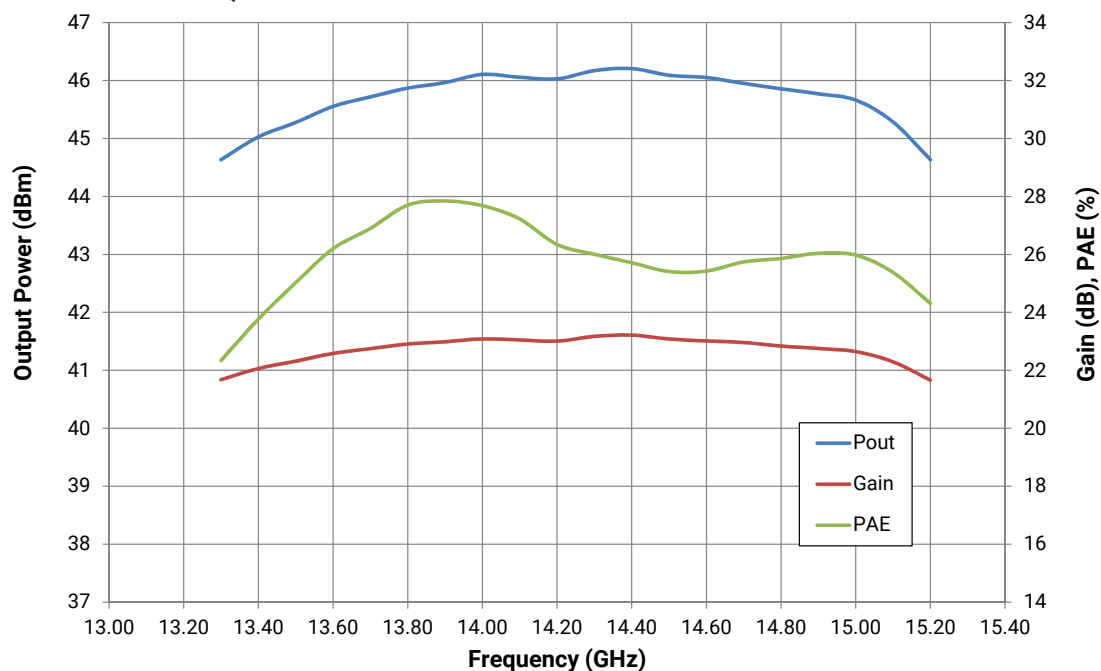


Figure 12. - Pulsed vs. Frequency @ $P_{IN} = 23\text{ dBm}$ CMPA1D1E025F in Test Fixture
 $V_{DD} = 40\text{ V}$, $I_{DQ} = 240\text{ mA}$, 100 μs Pulse Width, 10% Duty Cycle, $T_{case} = 25^{\circ}C$



Typical Performance

Figure 13. - Pulsed Power Sweep CMPA1D1E025F in Test Fixture
 10% Duty, 100 μ s Pulse Width
 $V_{DD} = 40V$, $I_{DQ} = 240$ mA, $T_{case} = 25^{\circ}C$

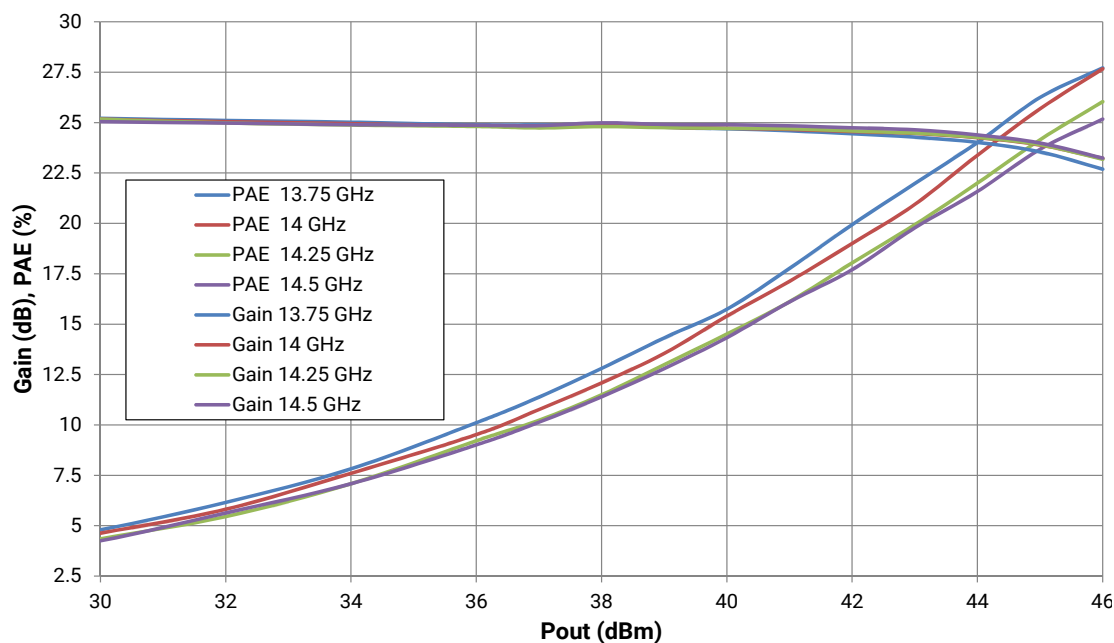
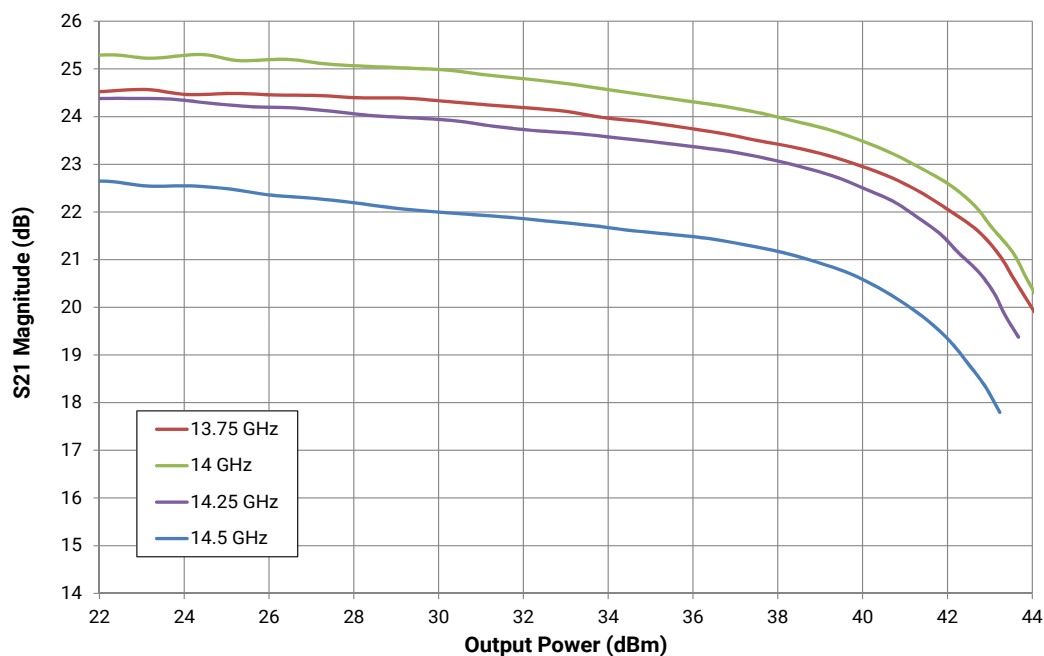


Figure 14. - AM-AM
 $V_{DD} = 40$ V, $I_{DQ} = 240$ mA, $T_{case} = 25^{\circ}C$



Typical Performance

Figure 15. - AM-PM
 $V_{DD} = 40\text{ V}$, $I_{DQ} = 240\text{ mA}$, $T_{case} = 25^\circ\text{C}$

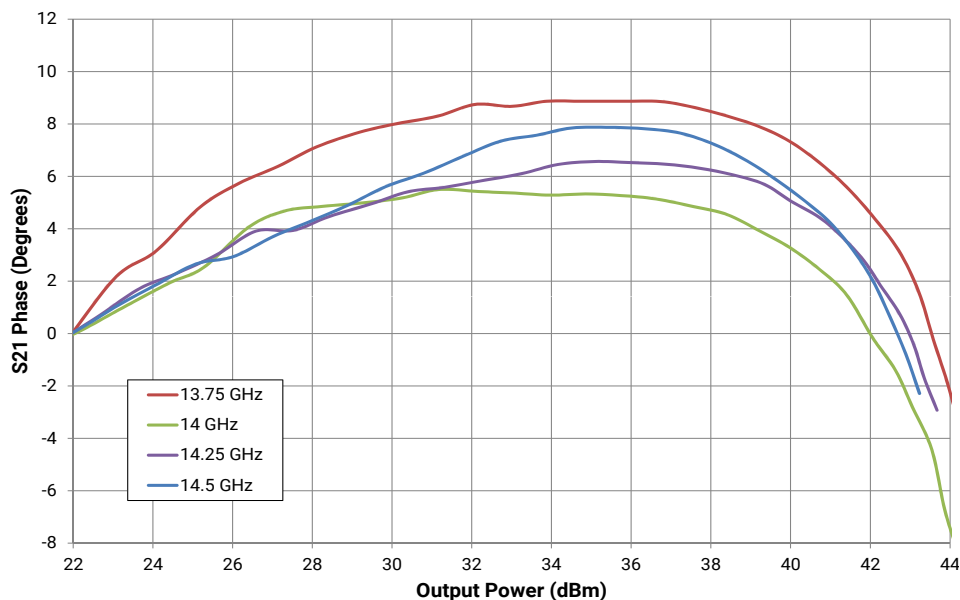
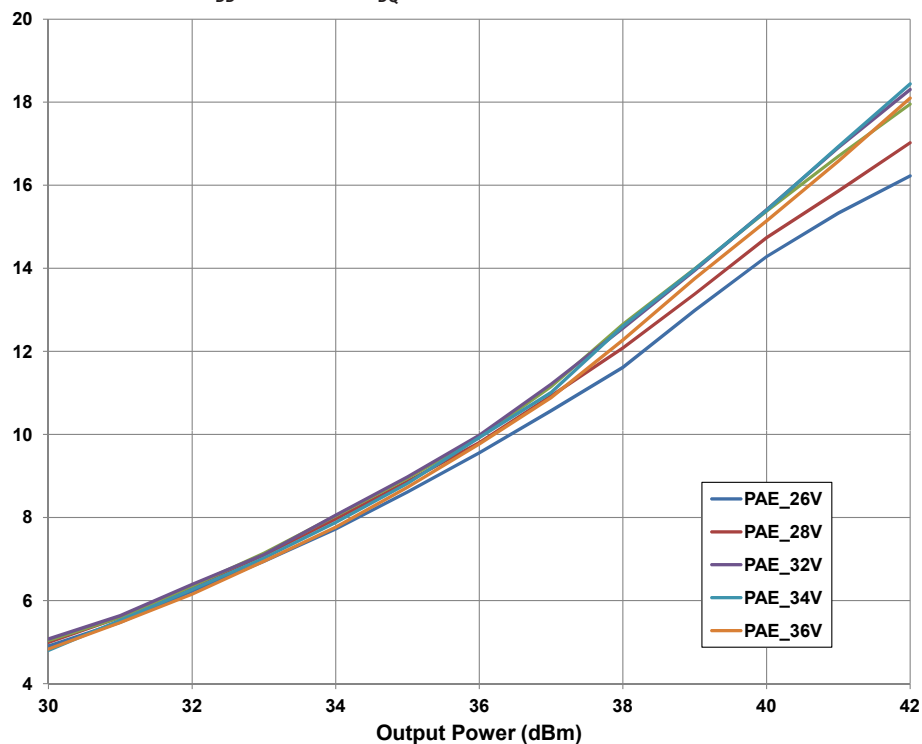


Figure 16. - CMPA1D1E025F Modulated Power Sweep (PAE and Gp)
 1.6 Msps OQPSK Modulation, Frequency = 14 GHz
 $V_{DD} = 26\text{-}36\text{ V}$, $I_{DQ} = 150\text{ mA}$, $T_{case} = 25^\circ\text{C}$



Typical Performance

Figure 17. - CPM1D1E025F Modulated Power Sweep (Gp)
 1.6 Msps OQPSK Modulation, Frequency = 14 GHz
 $V_{DD} = 26-36\text{ V}$, $I_{DQ} = 150\text{ mA}$, $T_{case} = 25^\circ\text{C}$

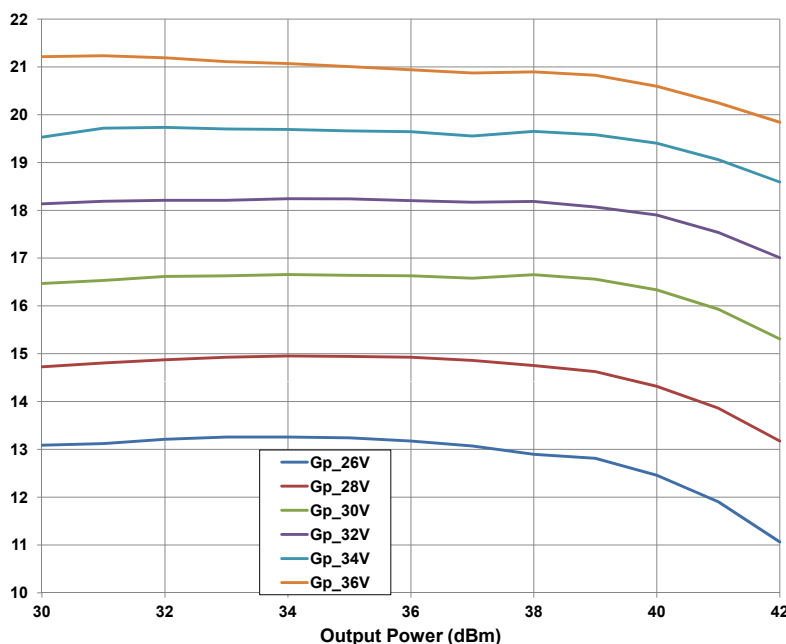
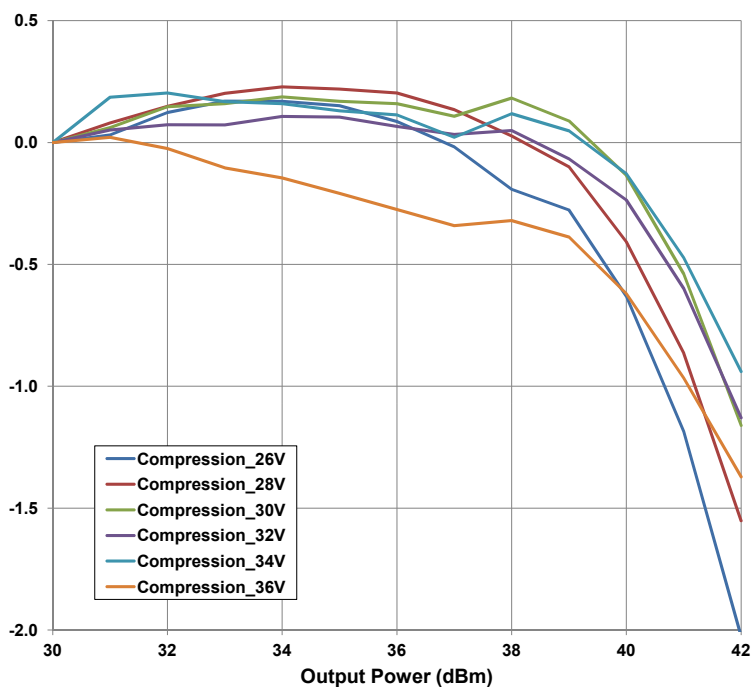
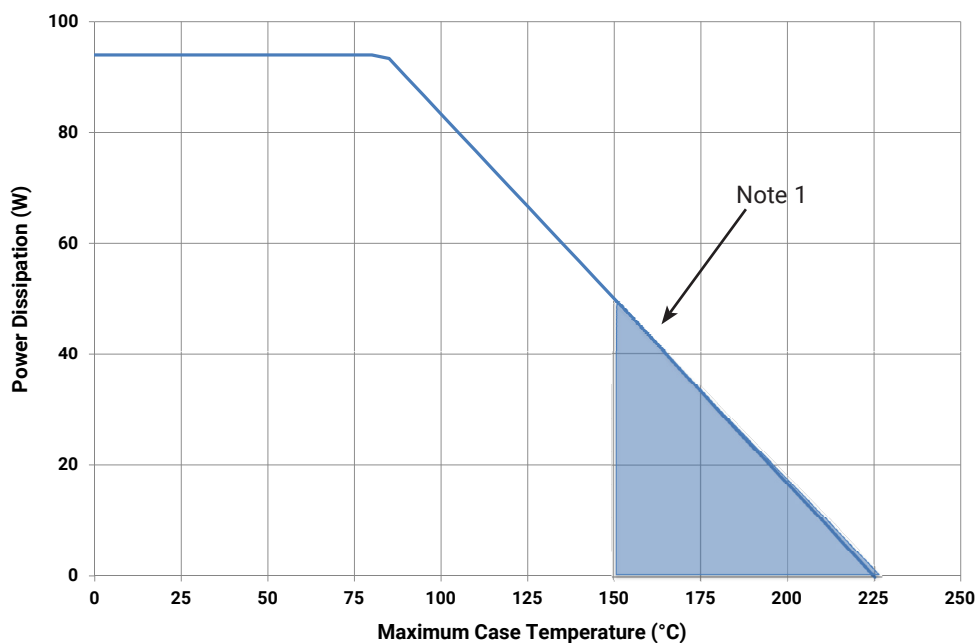


Figure 18. - CPM1D1E025F Modulated Power Sweep (Gain Compression)
 1.6 Msps OQPSK Modulation, Frequency = 14 GHz
 $V_{DD} = 26-36\text{ V}$, $I_{DQ} = 150\text{ mA}$, $T_{case} = 25^\circ\text{C}$



CMPA1D1E025F Power Dissipation De-rating Curve

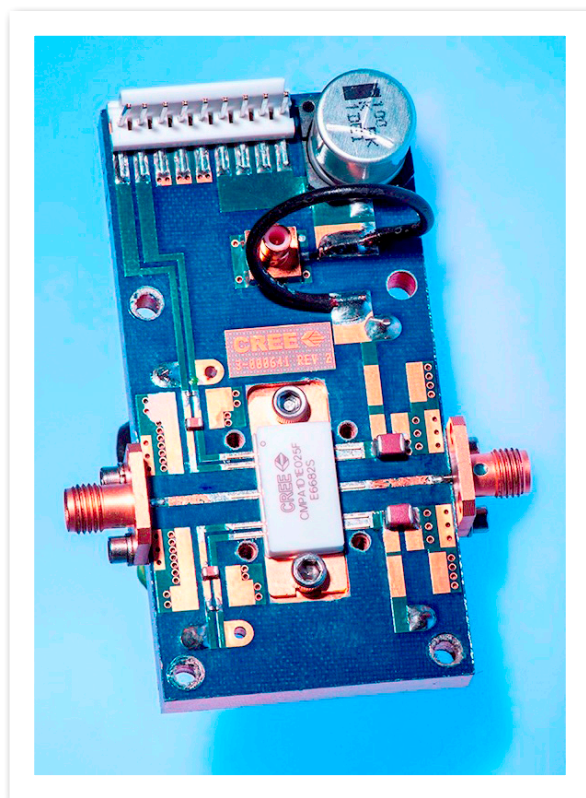


Note 1. Area exceeds Maximum Case Temperature (See Page 2).

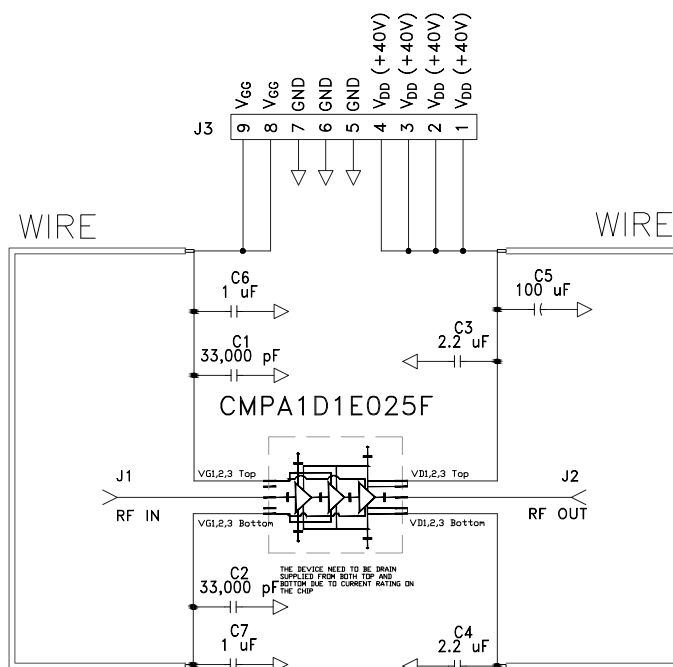
CMPA1D1E025F-AMP Demonstration Amplifier Circuit Bill of Materials

Designator	Description	Qty
C5	CAP ELECT 100UF 80V AFK SMD	1
C1, C2	CAP, 33000PF, 0805,100V, X7R	2
C3, C4	CAP, 2.2UF, 100V, 10%, X7R, 1210	2
C6, C7	CAP, 1.0UF, 100V, 10%, X7R, 1210	2
J1, J2	CONN, SMA, PANEL MOUNT JACK, FLANGE, 4-HOLE, BLUNT POST, 20MIL	2
J4	CONN, SMB, STRAIGHT JACK RECEPTACLE, SMT, 50 OHM, Au PLATED	1
J3	HEADER RT>PLZ .1CEN LK 9POS	1
W1, W2, W3	WIRE, BLACK, 22 AWG	1
	PCB, TEST FIXTURE, TACONICS RF35P, 20 MILS	1
	2-56 SOC HD SCREW 3/16 SS	4
-	#2 SPLIT LOCKWASHER SS	4
Q1	CMPA1D1E025F	1

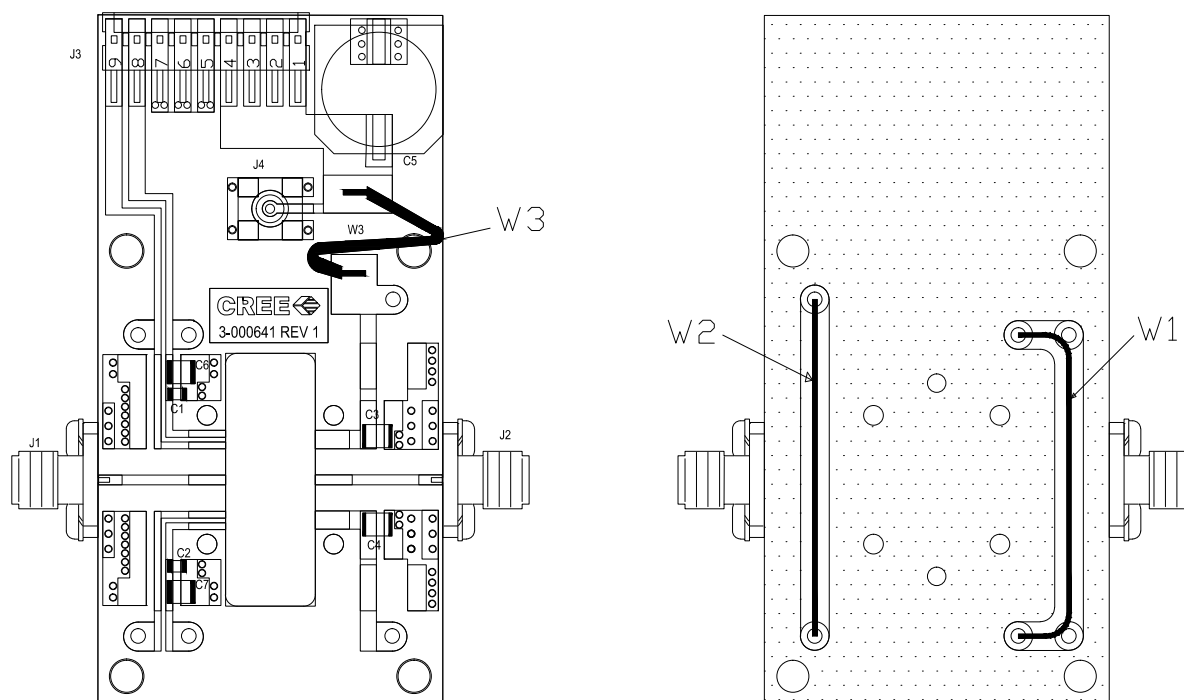
CMPA1D1E025F-AMP Demonstration Amplifier Circuit



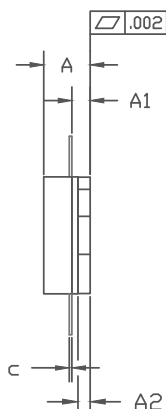
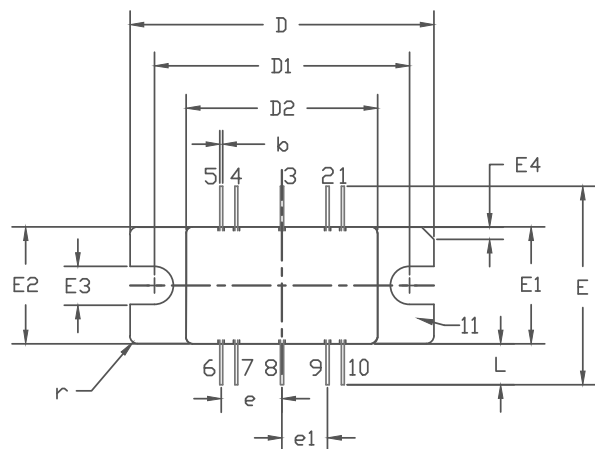
CMPA1D1E025F-AMP Demonstration Amplifier Circuit Schematic



CMPA1D1E025F-AMP Demonstration Amplifier Circuit Outline



Product Dimensions CMPA1D1E025F (Package Type – 440213)

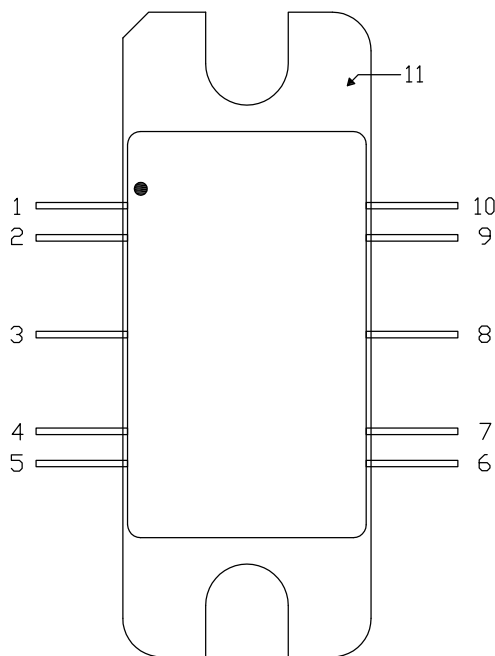


NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M - 1994.
2. CONTROLLING DIMENSION: INCH.
3. ADHESIVE FROM LID MAY EXTEND A MAXIMUM OF 0.020" BEYOND EDGE OF LID.
4. LID MAY BE MISALIGNED TO THE BODY OF PACKAGE BY A MAXIMUM OF 0.008" IN ANY DIRECTION.

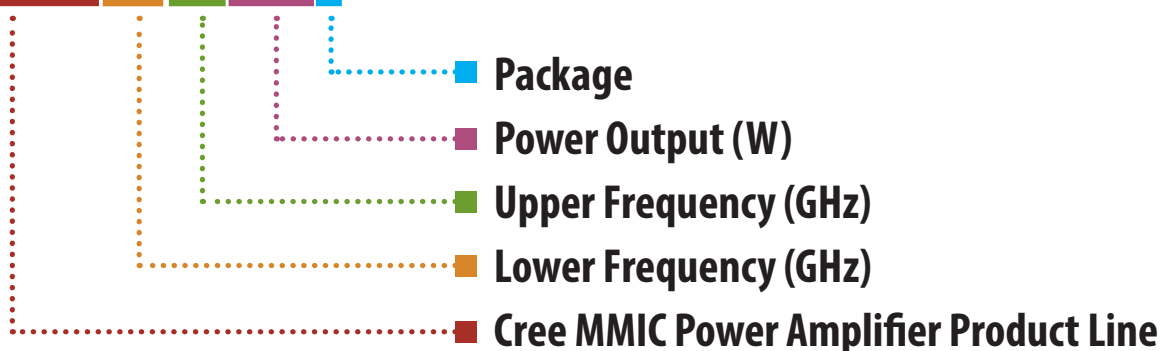
DIM	INCHES		MILLIMETERS		NOTES
	MIN	MAX	MIN	MAX	
A	0.148	0.168	3.76	4.27	
A1	0.055	0.065	1.40	1.65	
A2	0.035	0.045	0.89	1.14	
b	0.01 TYP		0.254 TYP		10x
c	0.007	0.009	0.18	0.23	
D	0.995	1.005	25.27	25.53	
D1	0.835	0.845	21.21	21.46	
D2	0.623	0.637	15.82	16.18	
E	0.653 TYP		16.59 TYP		
E1	0.380	0.390	9.65	9.91	
E2	0.380	0.390	9.65	9.91	
E3	0.120	0.130	3.05	3.30	
E4	0.035	0.045	0.89	1.14	45° CHAMFER
e	0.200 TYP		5.08 TYP		4x
e1	0.150 TYP		3.81 TYP		4x
L	0.115	0.155	2.92	3.94	10x
r	0.025 TYP		.635 TYP		3x

Pin Number	Qty
1	Gate Bias
2	NC
3	RF In
4	NC
5	Gate Bias
6	Drain Bias
7	Drain Bias
8	RF Out
9	Drain Bias
10	Drain Bias
11	Source



Part Number System

CMPA1D1E025F



Parameter	Value	Units
Lower Frequency	13.75	GHz
Upper Frequency ¹	14.5	GHz
Power Output	25	W
Package	Flange	-

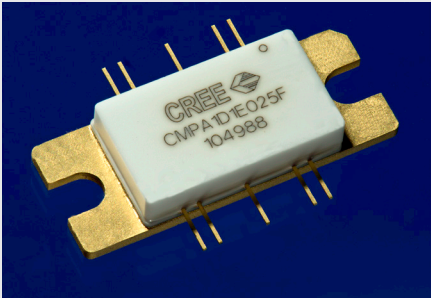
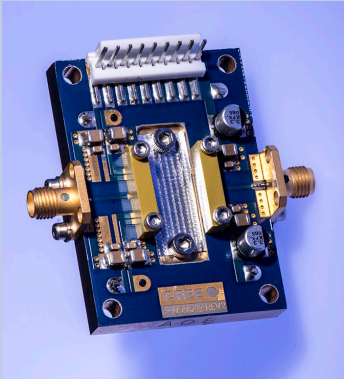
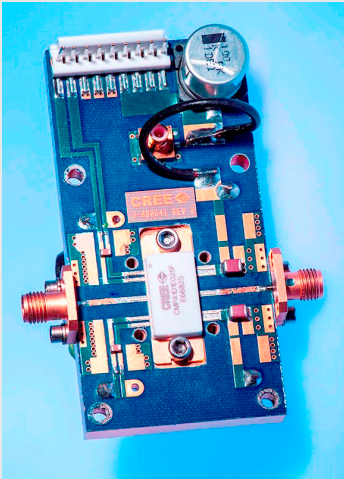
Table 1.

Note¹: Alpha characters used in frequency code indicate a value greater than 9.9 GHz. See Table 2 for value.

Character Code	Code Value
A	0
B	1
C	2
D	3
E	4
F	5
G	6
H	7
J	8
K	9
Examples:	1A = 10.0 GHz 2H = 27.0 GHz

Table 2.

Product Ordering Information

Order Number	Description	Unit of Measure	Image
CMPA1D1E025F	GaN HEMT	Each	
CMPA1D1E025F-TB	Test board without GaN HEMT	Each	
CMPA1D1E025F-AMP	Test board with GaN HEMT installed	Each	

Disclaimer

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